

Notice of References Cited	Application/Control No. 09/781,187	Applicant(s)/Patent Under Reexamination OGINO ET AL.	
	Examiner Huy Q Phan	Art Unit 2687	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,405,047 B1	06-2002	Moon, Yong-Woon	455/456.1
	B	US-6,671,377 B1	12-2003	Havinis et al.	380/258
	C	US-6,023,618 A	02-2000	Janhonen et al.	455/406
	D	US-6,681,099 B1	01-2004	Keranen et al.	455/67.16
	E	US-6,847,822 B1	01-2005	Dennison et al.	455/456.1
	F	US-2003/0146871 A1	08-2003	Karr et al.	342/457
	G	US-5,293,645 A	03-1994	Sood, Prem L.	455/456.2
	H	US-6,031,490 A	02-2000	Forssen et al.	342/457
	I	US-2004/0092275 A1	05-2004	Krasner et al.	455/502
	J	US-5,952,969 A	09-1999	Hagerman et al.	342/457
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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